

IQS-8120/8130

Transport Blazer

R&D AND MANUFACTURING – TRANSPORT AND DATACOM



Fully integrated test solution supporting next-generation SONET/SDH and optical transport network (OTN) test functions

- DS0/E0 to OC-192/STM-64/OTU2 testing in a single module
- Supports SONET, SDH, DS_n, PDH, next-generation SONET/SDH and OTN testing
- Ethernet-over-SONET/SDH (EoS) testing via GFP, VCAT and LCAS software options
- OTN forward error correction (FEC) and optical channel data unit (ODU) multiplex testing capabilities as per ITU-T G.709
- Offers ODU0 (1.25 Gbit/s) container with Gigabit Ethernet and SONET/SDH client signals for qualifying newly and efficiently mapped transport and datacom services over OTN
- Supports circuit and packet ODUflex testing capabilities for OTN bandwidth optimization
- SmartMode signal structure discovery for rates of up to 10 Gbit/s, with real-time simultaneous monitoring of all discovered STS/AU and user selected VT/TU channels
- Intuitive, feature-rich user interface with automated test scripting and multi-user remote management capabilities

Platform Compatibility

- IQS-600 Integrated Qualification System



The Next Step in SONET/SDH Testing

The increased demand for data and video services continues to drive the need for more cost-effective networks. Technologies such as next-generation SONET/SDH/OTN are becoming more important to service providers as they offer an economical means of introducing new revenue-generating, Ethernet-based transport services on existing SONET/SDH infrastructures. In addition, implementation of OTN (ITU-T G.709) will also help reduce the cost of operating DWDM networks by achieving higher transmission quality with longer optical links through the use of forward error correction (FEC).

This opportunity creates the need for test solutions that can help ensure proper deployment, operation and maintenance of standard SONET/SDH, OTN and new Ethernet-based transport networks.

EXFO's IQS-8120 (2.5/2.7 Gbit/s) and IQS-8130 (10/11.3 Gbit/s) Transport Blazer test modules provide advanced DS_n/PDH, SONET/SDH, next-generation SONET/SDH and OTN test functions in a single unit, eliminating the need for multiple, purpose-built test and measurement platforms when testing new data-aware SONET/SDH/OTN devices in lab or manufacturing environments.

SONET/SDH Testing and Troubleshooting

The IQS-8120/8130 Transport Blazer modules offer a wide range of SONET/SDH test functions, allowing users to perform tests ranging from simple bit error rate (BER) testing to advanced characterization and troubleshooting procedures. These functions include:

- Mixed and bulk payload generation and analysis from 64 kbit/s to 10 Gbit/s
- High-order mappings: STS-1/3c/12c/48c/192c and AU-3/AU-4/AU-4-4c/16c/64c
- Low-order mappings: VT1.5/2/6, TU-11/12/2/3
- Unframed optical signal testing at 10 Gbit/s rate
- Section/RS, Line/MS, high-order and low-order path overhead manipulation and monitoring
- Section/RS, Line/MS, high-order and low-order path alarm/error generation and monitoring
- High-order and low-order pointer generation and monitoring
- K1/K2 OH byte capture
- Tandem connection monitoring
- Performance monitoring: G.821, G.826, G.828, G.829, M.2100, M.2101
- Frequency analysis and power measurement
- Frequency offset generation
- Payload block and replace
- Automatic protection switching and service disruption time measurements
- Round-trip delay measurements
- DS1/DS3 auto detection of line code, framing and test pattern
- Dual DS1/DS3 receiver testing
- Independent transmitter and receiver testing
- Through mode analysis
- Intrusive Through mode
- Programmable error/alarm injection
- DS1 FDL
- DS1 loopcodes and NI/CSU loopback emulation
- Fractional T1/E1 testing
- DS3 FEAC

Optical Transport Network (OTN) Testing

OTN as per ITU-T G.709 has recently introduced two new concepts: ODU0 and ODUflex. ODU0 is a new virtual container of 1.25 Gbit/s bandwidth specifically defined for efficiently mapping Gigabit Ethernet services over OTN. As for ODUflex, it is the most efficient sub-wavelength bandwidth management capability for transport line rates of 10 Gbit/s, 40 Gbit/s and upcoming 100 Gbit/s. ODUflex allows providers to interconnect routers in ways that enable efficient bandwidth growth in steps of 1.25 Gbit/s, eliminating the need to allocate a full fixed-rate ODU container to each connection and allowing service providers to transport efficiently and seamlessly across lower-cost optical infrastructures.

With the demand for OTN-enabled devices rapidly increasing, so does the need for an integrated OTN test equipment. The IQS-8120/8130 Transport Blazer modules offer OTN test capabilities for verifying ITU-T G.709 standards compliance. The tests include:

- OTU1 (2.7 Gbit/s) and OTU2 (10.7 Gbit/s) bit rates
- ODU0 (1.25 Gbit/s) container with Gigabit Ethernet and SONET/SDH client signals mapping
- ODUflex with Ethernet client signal mapping
- Over-clocked OTU2 rates: OTU1e (11.0491 Gbit/s), OTU2e (11.0957 Gbit/s), OTU1f (11.2701 Gbit/s) and OTU2f (11.3176 Gbit/s)
- Unframed optical signal testing at 10.7 Gbit/s, 11.0491 Gbit/s, 11.0957 Gbit/s, 11.2701 Gbit/s and 11.3176 Gbit/s rates
- Synchronous mapping of SONET/SDH signals within OTN as well as synchronous and asynchronous demapping
- Forward error correction (FEC) testing
- Service disruption time (SDT) measurements
- Round-trip delay (RDT) measurements
- OTU, ODU, OPU overhead manipulation and monitoring
- OTU, ODU (including ODU TCM), OPU layer alarms/errors generation and analysis
- OTU, ODU (including ODU TCM) trace messages
- Mux/demux of ODU1/ODU2 testing—generation of four ODU1 into a single ODU2 structure and transporting it over a single wavelength
- ODU multiplexing alarm-generation and analysis
- Through mode analysis
- Intrusive Through mode
- EoOTN testing using internally generated 10 GigE LAN and mapping onto OTU1e and OTU2e rates
- 10 GigE LAN mapping into OTU2 using GFP-F

Multichannel VCAT Testing

The IQS-8120NG/8130NG Transport Blazer's virtual concatenation functionality supports real-time multichannel testing, allowing for each low-order (e.g., VT1.5, VT2, VC-11, VC-12) or high-order (e.g., STS-1/3, VC-3/4) path of a configured virtual concatenation group (VCG) to be controlled and monitored independently. This provides full visibility of all path errors and alarms per VCG member, critical for VCAT circuit troubleshooting. In addition, this multichannel visibility provides a means of generating simultaneous alarms and errors per member, ideal for lab verification applications, network simulation testing or device qualification.

IQS-8120/8130 SmartMode: multichannel signal discovery with real-time alarm scan.

Unsurpassed Configuration and Operational Flexibility

Next-Generation SONET/SDH Testing

EXFO's Transport Blazer series offers four hardware configurations:

- IQS-8120 supports SONET/SDH and OTN test functions to 2.7 Gbit/s
- IQS-8130 supports SONET/SDH and OTN test functions to 11.3 Gbit/s
- IQS-8120NG supports next-generation SONET/SDH and OTN test functions to 2.7 Gbit/s
- IQS-8130NG supports next-generation SONET/SDH and OTN test functions to 11.3 Gbit/s



■ IQS-8130 SONET/SDH/OTN



■ IQS-8130NG with next-generation SONET/SDH/OTN hardware including optical and electrical Ethernet add/drop interfaces

Product Option Flexibility

The Transport Blazer series is highly configurable and it affords customers the flexibility to customize their testing needs. Base SONET/SDH/OTN-only configurations can be easily upgraded to next-generation test functions as new needs arise. This eliminates the need to perform complete hardware and/or platform retrofits, therefore significantly decreasing capital and training expenses.

With the IQS-8120NG and IQS-8130NG Transport Blazer modules, have the choice of purchasing one or more next-generation options (e.g., GFP, VCAT, LCAS) to create a custom configuration to suit their testing needs. At any point, additional next-generation options are available via simple on-site upgrades.

Remote Management

The IQS-8120/8130 Transport Blazer modules, through their optional Visual Guardian Lite™ management software, allow users to perform remote testing and data analysis, as well as remote monitoring via standard Ethernet.

Automated Test Scripting

The IQS-8120/8130 Transport Blazer modules support two methods for automated test scripting. First, by using industry-based SCPI commands, and second, by using a built-in macro recorder that facilitates the recording of test actions and allows to automatically create test scripts.

Test Logger and Reporting

EXFO's IQS-8120/8130 Transport Blazer modules support a detailed test logger and test reporting tools, enabling users to view any errors/alarms that occurred during the test interval, which can then be used for post-processing results or SLA conformance validation.

IQS-600 Integrated Qualification System

The IQS-8120NG/8130NG Transport Blazer modules are housed in the IQS-600 Integrated Qualification System, a scalable modular rack-mount platform that houses a controller, expansion units and a comprehensive range of plug-in test modules ideal for manufacturing, lab and R&D environments. The IQS-600 platform offers up to ten slots that can support any combination of modules from EXFO's full range of industry-proven protocol and optical test modules. Systems can be expanded to support up to 100 test modules. The IQS-600 family is comprised of the IQS-610P, a ten-slot control unit that can support up to nine IQS-610E 10-slot expansion units, and the IQS-605P, a five-slot control unit with an integrated touchscreen.

Combined with the built-in IQS Manager software, the IQS-600 platform provides an easy-to-use environment to manage your modules, configure your system, launch applications and analyze results. What's more, it can be controlled using local applications or through GPIB, RS-232 or Ethernet interfaces.



■ EXFO's IQS-8120/8130 Transport Blazer Test Modules are housed in the IQS-600 Integrated Qualification System, EXFO's powerful lab/manufacturing test platform.

Electrical Interfaces

The following section provides detailed information on all supported electrical interfaces.

	DS1	E1/2M	E2/8M	E3/34M	DS3/45M	STS-1e/STM-0e/52M	E4/140M	STS-3e/STM-1e/155M
Tx pulse amplitude	2.4 to 3.6 V	3.0 V	2.37 V	2.37 V	1.0 ± 0.1 V	0.36 to 0.85 V	1.0 ± 0.1 V _{pp}	0.5 V
Tx pulse mask	GR-499 Figure 9.5	G.703 Figure 15	G.703 Figure 15	G.703 Figure 16	G.703 Figure 17	DS-3 GR-499 Figure 9-8 45-M G.703 Figure 14	GR-253 Figure 4-10/4-11	G.703 Figure 18/19 STS-3e GR-253 Figure 4-12/4-13/4-14 STM-1e/155M G.703 Figure 4-14/22, 23
Tx LBO preamplification	Power dBdsx +0.6 dBdsx (0-133 ft) +1.2 dBdsx (133-266 ft) +1.8 dBdsx (266-399 ft) +2.4 dBdsx (399-533 ft) +3.0 dBdsx (533-655 ft)					0 to 225 ft 225 to 450 ft	0 to 225 ft 255 to 450 ft	0 to 225 ft
Cable simulation	Power dBdsx -22.5 dBdsx -15.0 dBdsx -7.5 dBdsx 0 dBdsx					450 to 900 (927) ft	450 to 900 (927) ft	
Rx level sensitivity	For 772 kHz: TERM: ≤26 dB (cable loss only) at 0 dBdsx Tx DSX-MON: ≤26 dB (20 dB resistive loss + cable loss ≤ 6 dB) Bridge: ≤6 dB (cable loss only) Note: measurement units = dBdsx	For 1024 kHz: TERM: ≤6 dB (cable loss only) MON: ≤25 dB (20 dB resistive loss + cable loss ≤ 6 dB) Bridge: ≤6 dB (cable loss only) Note: measurement units = dBm	For 1024 kHz: TERM: ≤6 dB (cable loss only) MON: ≤26 dB (20 dB resistive loss + cable loss ≤ 6 dB) Bridge: ≤6 dB (cable loss only) Note: measurement units = dBm	For 4224 kHz: TERM: ≤6 dB (cable loss only) MON: ≤26 dB (20 dB resistive loss + cable loss ≤ 6 dB) Note: measurement units = dBm	For 17.184 MHz: TERM: ≤12 dB (coaxial cable loss only) MON: ≤26 dB (20 dB resistive loss + cable loss ≤ 6 dB) Note: measurement units = dBm	For 22.368 MHz: TERM: ≤10 dB (cable loss only) DSX-MON: ≤26.5 dB (21.5 dB resistive loss + cable loss ≤ 5 dB) Note: measurement units = dBm	For 25.92 MHz: TERM: ≤10 dB (cable loss only) MON: ≤25 dB (20 dB resistive loss + cable loss ≤ 5 dB) Note: measurement units = dBm	For 70 MHz: TERM: ≤12 dB (coaxial cable loss only) MON: ≤26 dB (20 dB resistive loss + cable loss ≤ 6 dB) Note: measurement units = dBm
Tx bit rate	1.544 Mbit/s ± 4.6 ppm	2.048 Mbit/s ± 4.6 ppm	2.048 Mbit/s ± 4.6 ppm	8.448 Mbit/s ± 4.6 ppm	34.368 Mbit/s ± 4.6 ppm	44.736 Mbit/s ± 4.6 ppm	51.84 Mbit/s ± 4.6 ppm	139.264 Mbit/s ± 4.6 ppm
Rx bit rate	1.544 Mbit/s ± 140 ppm	2.048 Mbit/s ± 100 ppm	2.048 Mbit/s ± 100 ppm	8.448 Mbit/s ± 100 ppm	34.368 Mbit/s ± 100 ppm	44.736 Mbit/s ± 100 ppm	51.84 Mbit/s ± 100 ppm	139.264 Mbit/s ± 100 ppm
Measurement accuracy (uncertainty)								
Frequency	±4.6 ppm	±4.6 ppm	±4.6 ppm	±4.6 ppm	±4.6 ppm	±4.6 ppm	±4.6 ppm	±4.6 ppm
Electrical power	DSX range: ±1.0 dB DSX-MON range: ±2.0 dB	Normal: ±1.0 dB Monitor: ±2.0 dB	Normal: ±1.0 dB Monitor: ±2.0 dB	Normal: ±1.0 dB Monitor: ±2.0 dB	Normal: ±1.0 dB Monitor: ±2.0 dB	DSX range: ±1.0 dB DSX-MON range: ±2.0 dB	DSX range: ±1.0 dB DSX-MON range: ±2.0 dB	Normal: ±1.0 dB Monitor: ±2.0 dB
Peak-to-peak voltage	±10 % down to 500 mV _{pp}	±10 % down to 500 mV _{pp}	±10 % down to 500 mV _{pp}	±10 % down to 400 mV _{pp}	±10 % down to 200 mV _{pp}	±10 % down to 200 mV _{pp}	±10 % down to 200 mV _{pp}	±10 % down to 200 mV _{pp}
Frequency offset generation	1.544 Mbit/s ± 140 ppm	2.048 Mbit/s ± 70 ppm	2.048 Mbit/s ± 70 ppm	8.448 Mbit/s ± 50 ppm	34.368 Mbit/s ± 50 ppm	44.736 Mbit/s ± 50 ppm	51.84 Mbit/s ± 50 ppm	139.264 Mbit/s ± 50 ppm
Intrinsic jitter (Tx)	ANSI T1.403 section 6.3 GR-499 section 7.3	G.823 section 5.1	G.823 section 5.1	G.823 section 5.1	G.823 section 5.1 G.751 section 2.3	GR-449 section 7.3 (categories I and II)	GR-253 section 5.6.2.2 (category II)	G.823 section 5.1 GR-253 section 5.6.2.2
Input jitter tolerance	AT&T PUB 62411 GR-499 section 7.3	G.823 section 7.1	G.823 section 7.1	G.823 section 7.1	G.823 section 7.1	GR-449 section 7.3 (categories I and II)	GR-253 section 5.6.2.2 (category II)	G.823 section 7.1 G.751 section 3.3 GR-253 section 5.6.2.3
Line coding	AMI and B8ZS	AMI and HDB3	AMI and HDB3	HDB3	HDB3	B3ZS	B3ZS	CMI
Input impedance	100 Ω ± 5 %, balanced	120 Ω ± 5 %, balanced	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced
Connector type	BANTAM and RJ-48C	BANTAM and RJ-48C	BNC	BNC	BNC	BNC	BNC	BNC

SYNCHRONISATION INTERFACES

	External Clock DS1/1.5M	External Clock E1/2M	External Clock E1/2M	2 MHz (Trigger)
Tx pulse amplitude	2.4 to 3.6 V	3.0 V	2.37 V	0.75 to 1.5 V
Tx pulse mask	GR-499 figure 9.5	G.703 figure 15	G.703 figure 15	G.703 figure 20
Tx LBO preamplification	Typical power dBdsx +0.6 dBdsx (0-133 ft) +1.2 dBdsx (133-266 ft) +1.8 dBdsx (266-399 ft) +2.4 dBdsx (399-533 ft) +3.0 dBdsx (533-655 ft)			
Rx level sensitivity	TERM: ≤6 dB (cable loss only) (at 772 kHz for T1) DSX-MON: ≤26 dB (20 dB resistive loss + cable loss ≤ 6 dB) Bridge: ≤6 dB (cable loss only)	TERM: ≤6 dB (cable loss only) MON: ≤26 dB (20 dB resistive loss + cable loss ≤ 6 dB) Bridge: ≤6 dB (cable loss only)	TERM: ≤6 dB (cable loss only) MON: ≤26 dB (resistive loss + cable loss ≤ 6 dB) Bridge: ≤6 dB (cable loss only)	≤6 dB (cable loss only)
Tx bit rate	1.544 Mbit/s ± 4.6 ppm	2.048 Mbit/s ± 4.6 ppm	2.048 Mbit/s ± 4.6 ppm	
Rx bit rate	1.544 Mbit/s ± 50 ppm	2.048 Mbit/s ± 50 ppm	2.048 Mbit/s ± 50 ppm	
Intrinsic jitter (Tx)	ANSI T1.403 section 6.3 GR-499 section 7.3	G.823 section 6.1	G.823 section 6.1	G.703 table 11
Input jitter tolerance	AT&T PUB 62411 GR-499 SECTION 7.3	G.823 section 7.2 G.813	G.823 section 7.2 G.813	
Line coding	AMI and B8ZS	AMI and HDB3	AMI and HDB3	
Input impedance (resistive termination)	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced	75 Ω ± 5 %, unbalanced
Connector type	BNC ^a	BNC ^a	BNC	BNC

NOTE

- a. Adaptation cable required for BANTAM.

Electrical Interfaces

ETHERNET ADD/DROP INTERFACE

10/100/1000 Base-T (Add/Drop)

Compliance	10 Mbit/s: IEEE 802.3 section 14
	100 Mbit/s: IEEE 802.3 section 25
	1000 Mbit/s: IEEE 802.3 section 40

Connector	RJ-45 Ethernet
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Gigabit Ethernet (Add/Drop)

Interface/connector	SFP/Dual LC
Compliance	1000 Mbit/s: IEEE 802.3 Section 40 ^a
Wavelength/Max Tx level	850, 1310 nm/-3 dBm
	1550 nm/+5 dBm

REF-OUT INTERFACE

Parameter	Value					
Tx pulse amplitude	600 ± 150 mVpp					
Transmission frequency	SONET/SDH	OTU2	OTU1e	OTU2e	OTU1f	OTU2f
Clock divider = 16	622.08 MHz	669.33 MHz	690.57 MHz	693.48 MHz	704.38 MHz	707.35 MHz
Clock divider = 32	311.04 MHz	334.66 MHz	345.29 MHz	346.74 MHz	352.19 MHz	353.68 MHz
Clock divider = 64	155.52 MHz	167.33 MHz	172.64 MHz	173.37 MHz	176.10 MHz	176.84 MHz
Output configuration	AC coupled					
Load impedance	50 ohms					
Maximum cable length	3 meters					
Connector Type	SMA					

SONET/SDH/OTN Optical Interfaces

The following section provides detailed information on all supported SONET/SDH/OTN optical interfaces.

		OC-3/STM-1				OC-12/STM-4				OC-48/STM-16/OTU1				OC-192/STM-64/OTU2			
		15 km; 1310 nm	40 km; 1310 nm	40 km; 1550 nm	80 km; 1550 nm	15 km; 1310 nm	40 km; 1310 nm	40 km; 1550 nm	80 km; 1550 nm	15 km; 1310 nm	40 km; 1310 nm	40 km; 1550 nm	80 km; 1550 nm	10 km; 1310 nm	40 km; 1550 nm	80 km; 1550 nm	
Level Tx		-5 to 0 dBm	-2 to 3 dBm	-5 to 0 dBm	-2 to 3 dBm	-5 to 0 dBm	-2 to 3 dBm	-5 to 0 dBm	-2 to 3 dBm	-5 to 0 dBm	-2 to 3 dBm	-5 to 0 dBm	-2 to 3 dBm	-6 to -1 dBm	-1 to 2 dBm	0 to 4 dBm	
Rx operating range		-23 to -10 dBm	-30 to -15 dBm	-23 to -10 dBm	-30 to -15 dBm	-22 to 0 dBm	-27 to -9 dBm	-22 to 0 dBm	-29 to -9 dBm	-18 to 0 dBm	-27 to -9 dBm	-18 to 0 dBm	-28 to -9 dBm	-11 to -1 dBm	-14 to -1 dBm	-24 to -9 dBm	
Transmit bit rate		155.52 Mbit/s ± 4.6 ppm				622.08 Mbit/s ± 4.6 ppm				2.48832 Gbit/s ± 4.6 ppm 2.66606 Gbit/s ± 4.6 ppm (OTU1)				9.95328 Gbit/s ± 4.6 ppm (OC-192/STM-64) 10.70922 Gbit/s ± 4.6 ppm (OTU2) 11.0491 Gbit/s ± 4.6 ppm (OTU1e) 11.0957 Gbit/s ± 4.6 ppm (OTU2e) 11.2701 Gbit/s ± 4.6 ppm (OTU1f) 11.3176 Gbit/s ± 4.6 ppm (OTU2f)		9.95328 Gbit/s ± 4.6 ppm 10.70922 Gbit/s ± 4.6 ppm (OTU2)	
Receive bit rate		155.52 Mbit/s ± 100 ppm				622.08 Mbit/s ± 100 ppm				2.48832 Gbit/s ± 100 ppm 2.66606 Gbit/s ± 100 ppm (OTU1)				9.95328 Gbit/s ± 100 ppm (OC-192/STM-64) 10.70922 Gbit/s ± 100 ppm (OTU2) 11.0491 Gbit/s ± 120 ppm (OTU1e) 11.0957 Gbit/s ± 120 ppm (OTU2e) 11.2701 Gbit/s ± 120 ppm (OTU1f) 11.3176 Gbit/s ± 120 ppm (OTU2f)		9.95328 Gbit/s ± 100 ppm 10.70922 Gbit/s ± 100 ppm (OTU2)	
Operational wavelength range		1261 to 1360 nm	1263 to 1360 nm	1430 to 1580 nm	1480 to 1580 nm	1270 to 1360 nm	1280 to 1335 nm	1430 to 1580 nm	1480 to 1580 nm	1260 to 1360 nm	1280 to 1335 nm	1430 to 1580 nm	1500 to 1580 nm	1290 to 1330 nm		1530 to 1565 nm	1530 to 1565 nm
Spectral width		1 nm (-20 dB)				1 nm (-20 dB)				1 nm (-20 dB)				1 nm (-20 dB)			
Frequency offset generation		± 50 ppm				± 50 ppm				± 50 ppm				± 50 ppm ^b			
Measurement accuracy (uncertainty)	Frequency Optical power	± 4.6 ppm ± 2 dB				± 4.6 ppm ± 2 dB				± 4.6 ppm ± 2 dB				± 4.6 ppm ± 2 dB			
Maximum Rx before damage ^c		3 dBm				3 dBm				3 dBm				3 dBm			
Jitter compliance		GR-253 (SONET) G.958 (SDH)				GR-253 (SONET) G.958 (SDH)				GR-253 (SONET) G.958 (SDH) G.8251 (OTN)				GR-253 (SONET) G.825 (SDH) G.8251 (OTN)			
Line coding		NRZ				NRZ				NRZ				NRZ			
Eye safety		SFP/XFP transceivers comply with IEC 60825 and 21 CFR 1040.10 (except for deviations pursuant to Laser Notice No. 50, dated July 2001), for Class 1 or 1M lasers.															
Connector ^d		Dual LC				Dual LC				Dual LC				Dual LC			
Transceiver type ^e		SFP				SFP				SFP				XFP			

NOTES

- SFP/XFP transceivers comply with IEC 60825 and 21 CFR 1040.10 (except for deviations pursuant to Laser Notice 50, dated July, 2001), for Class 1 or 1M lasers.
- For OTU1e, OTU2e, OTU1f and OTU2f rates, the frequency offset generation is ±115 ppm.
- In order not to exceed the maximum receiver power level before damage, an attenuator must be used.
- External adaptors can be used for other types of connectors. For example FC/PC.
- SFP compliance: The IQS-8120/8130 selected SFP/XFP shall meet the requirements stated in the "Small Form-Factor Pluggable (SFP) Transceiver Multisource Agreement (MSA)".
The IQS-8120/8130 selected SFP/XFP shall meet the requirements stated in the "Specification for Diagnostic Monitoring Interface for Optical Xcvrs".

SONET/SDH Functional Specifications

SONET AND DS _n		SDH AND PDH	
Optical interfaces	OC-3, OC-12, OC-48, OC-192	Optical interfaces	STM-1, STM-4, STM-16, STM-64
Available wavelengths (nm)	1310, 1550	Available wavelengths (nm)	1310, 1550
Electrical interfaces	DS1, DS3, STS-1e, STS-3e	Electrical interfaces ^a	1.5M (DS1), 2M (E1), 8M (E2), 34M (E3), 45M (DS3), 140M (E4), STM-0e, STM-1e
DS1 framing	Unframed, SF, ESF	2M framing	Unframed, PCM30, PCM31, PCM30 CRC-4, PCM31 CRC-4
DS3 framing	Unframed, M13, C-bit parity	8M, 34M, 140M framing	Unframed, framed
Clocking	Internal, loop-timed, external (BITS), inter-module	Clocking	Internal, loop-timed, external (MTS/SETS), 2 MHz, inter-module
Mappings ^b		Mappings ^b	
VT1.5	Bulk, DS1, GFP ^c	TU-11-AU-3, TU-11-AU-4	Bulk, 1.5M, GFP ^c
VT2	Bulk, E1, GFP ^c	TU-12-AU-3, TU-12-AU-4	Bulk, 1.5M, 2M, GFP ^c
VT6	Bulk, GFP ^c	TU-3-AU-4	Bulk, 34M, 45M, GFP ^c
STS-1 SPE	Bulk, DS3, GFP ^c	TU-2-AU-3, TU-2-AU-4	Bulk, GFP ^c
STS-3c	Bulk, E4, GFP ^c	AU-4	Bulk, 140M, GFP ^c
STS-12c/48c/192c, SPE	Bulk, GFP ^c	AU-4-4c/16c/64c	Bulk, GFP ^c
SONET overhead analysis and manipulation	A1, A2, J0, E1, F1, D1-D12, K1, K2, S1, M0, E2, J1, C2, G1, F2, H4, Z3, Z4, Z5, N1, N2, Z6, Z7	SDH overhead analysis and manipulation	A1, A2, J0, E1, F1, D1-D12, K1, K2, S1, M0, G1, F2, F3, K3, N1, N2, K4, E2, J1, C2, H4
Error insertion		Error insertion	
DS1	Framing bit, BPV, CRC-6, bit error	E1 (2M)	Bit error, FAS, CV, CRC-4, E-bit
DS3	BPV, C-bit, F-bit, P-bit, FEBE, bit error	E2 (8M), E3 (34M), E4 (140M)	Bit error, FAS, CV
STS-1e, STS-3e	Section BIP (B1), line BIP (B2), path BIP (B3), BIP-2, REI-L, REI-P, REI-V, BPV, FAS, bit error	STM-0e, STM-1e	RS-BIP (B1), MS-BIP (B2), HP-BIP (B3), MS-REI, HP-REI, LP-BIP-2, LP-REI, CV, FAS, bit error
OC-3, OC-12, OC-48, OC-192	Section BIP (B1), line BIP (B2), path BIP (B3), BIP-2, REI-L, REI-P, REI-V, FAS, bit error	STM-1, STM-4, STM-16, STM-64	RS-BIP (B1), MS-BIP (B2), HP-BIP (B3), MS-REI, HP-REI, LP-BIP-2, LP-REI, FAS, bit error
Error measurement		Error measurement	
DS1	Framing bit, BPV, CRC-6, excess zeros, bit error	E1 (2M)	Bit error, FAS, CV, CRC-4, E-bit
DS3	BPV, C-bit, F-bit, P-bit, FEBE, bit error	E2 (8M), E3 (34M), E4 (140M)	Bit error, FAS, CV
STS-1e, STS-3e	Section BIP (B1), line BIP (B2), path BIP (B3), BIP-2, REI-L, REI-P, REI-V, BPV, FAS, bit error	STM-0e, STM-1e	RS-BIP (B1), MS-BIP (B2), HP-BIP (B3), MS-REI, HP-REI, LP-BIP-2, LP-REI, CV, FAS, bit error
OC-3, OC-12, OC-48, OC-192	Section BIP (B1), line BIP (B2), path BIP (B3), BIP-2, REI-L, REI-P, REI-V, FAS, bit error	STM-1, STM-4, STM-16, STM-64	RS-BIP (B1), MS-BIP (B2), HP-BIP (B3), MS-REI, HP-REI, LP-BIP-2, LP-REI, CV, FAS, bit error
Alarm insertion		Alarm insertion	
DS1	LOS, RAI, AIS, OOF, pattern loss	E1 (2M)	LOS, LOS Mframe, LOS CRC Mframe, LOF, AIS, TS16 AIS, RAI, RAI Mframe, pattern loss
DS3	LOS, RDI, AIS, OOF, DS3 idle, pattern loss	E2 (8M), E3 (34M), E4 (140M)	LOS, LOF, RAI, AIS, pattern loss
STS-1e, STS-3e, OC-3, OC-12, OC-48, OC-192	LOS, LOF, SEF, AIS-L, RDI-L, AIS-P, LOP-P, LOM, PDI-P, RDI-P, ERDI-PCD, ERDI-PPD, ERDI-PSD, UNEQ-P, AIS-V, LOP-V, RDI-V, ERDI-VCD, ERDI-VPD, ERDI-VSD, RFI-V, UNEQ-V, pattern loss	STM-0e, STM-1e, STM-1, STM-4, STM-16, STM-64	LOS, LOF, OOF, MS-AIS, MS-RDI, AU-AIS, AU-LOP, H4-LOM, HP-PDI, ERDI-PSD, ERDI-PCD, ERDI-PPD, HP-UNEQ, TU-AIS, LP-RFI, LP-RDI, ERDI-VCD, ERDI-VPD, ERDI-VSD, LP-RFI, LP-UNEQ, pattern loss
Alarm detection		Alarm detection	
DS1	LOS, loss of clock (LOC), RAI, AIS, OOF, pattern loss	E1 (2M)	LOS, LOS Mframe, LOS CRC Mframe, LOC, LOF, AIS, TS16 AIS, RAI, RAI Mframe, pattern loss
DS3	LOS, LOC, RDI, AIS, OOF, DS3 idle, pattern loss	E2 (8M), E3 (34M), E4 (140M)	LOS, LOC, LOF, RAI, AIS, pattern loss
STS-1e, STS-3e, OC-3, OC-12, OC-48, OC-192	LOS, LOC, SEF, TIM-S, AIS-L, RDI-L, AIS-P, LOP-P, LOM, PDI-P, RDI-P, ERDI-PCD, ERDI-PPD, ERDI-PSD, PLM/SLM-P, UNEQ-P, TIM-P, AIS-V, LOP-V, RDI-V, ERDI-VCD, ERDI-VCD, ERDI-VPD, ERDI-VSD, RFI-V, UNEQ-V, TIM-V, PLM/SLM-V, pattern loss	STM-0e, STM-1e, STM-1, STM-4, STM-16, STM-64	LOS, LOC, LOF, OOF, RS-TIM, MS-AIS, MS-RDI, AU-AIS, AU-LOP, H4-LOM, HP-RDI, ERDI-PSD, ERDI-PCD, ERDI-PPD, HP-PLM/SLM, HP-UNEQ, HP-TIM, TU-AIS, LP-RFI, LP-RDI, ERDI-VPD, ERDI-VSD, LP-RFI, LP-UNEQ, LP-TIM, LP-PLM/SLM, pattern loss
Frequency alarm on all supported interfaces.			
Patterns		Patterns	
DS0	2E9-1, 2E11-1, 2E20-1, 1100, 1010, 1111, 0000, 1-in-8, 1-in-16, 3-in-24, 32 bit programmable (inverted or non-inverted), bit errors	E0 (64K)	2E9-1, 2E11-1, 2E20-1, 1100, 1010, 1111, 0000, 1-in-8, 1-in-16, 3-in-24, 32 bit programmable (inverted or non-inverted), bit errors
DS1	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, QRSS, 1-in-8, 1-in-16, 3-in-24, 32 bit programmable (inverted or non-inverted), T1-DALY, 55-Octet, bit errors	E1 (2M)	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, 1-in-8, 1-in-16, 3-in-24, 32 bit programmable (inverted or non-inverted), bit errors
DS3	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, QRSS, 1-in-8, 1-in-16, 3-in-24, 32 bit programmable (inverted or non-inverted), bit errors	E2 (8M), E3 (34M), E4 (140M)	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, 1-in-8, 1-in-16, 3-in-24 d, 32 bit programmable (inverted or non-inverted), bit errors
VT1.5/2/6	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, QRSS, 1-in-8, 1-in-16, 32 bit programmable (inverted or non-inverted), bit errors	TU-11/12/2/3	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, 1-in-8, 1-in-16, 32 bit programmable (inverted or non-inverted), bit errors
STS-1, STS-3c/12c/48c/192c	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, 1-in-8, 1-in-16, 32 bit programmable (inverted or non-inverted), bit errors	AU-3/AU-4/AU-4-4c/16c/64c	2E9-1, 2E11-1, 2E15-1, 2E20-1, 2E23-1, 2E31-1, 1100, 1010, 1111, 0000, 1-in-8, 1-in-16, 32 bit programmable (inverted or non-inverted), bit errors
Pattern loss and bit error generation and analysis supported on all patterns.			

NOTES

- 1.5M (DS1) and 45M (DS3) interfaces described under SONET and DS_n column.
- VCAT mappings are also available. Please refer to the VCAT section of this document for details.
- GFP supported only with purchase of GFP-F option.
- Not supported for E4 (140M).

SONET/SDH Functional Specifications (Cont'd)

NEXT-GENERATION SONET		NEXT-GENERATION SDH	
Generic framing procedure (GFP)		Generic framing procedure (GFP)	
Standards compliance	As per ITU-T G.7041, and ANSI T1.105.02	Standards compliance	As per ITU-T G.7041, G.707, and ANSI T1.105.02
Payload	PRBS pattern; Ethernet	Payload	PRBS pattern; Ethernet
Ethernet add/drop	Ability to add/drop Ethernet payload to/from GFP mapped OC-n/OTU signal	Ethernet add/drop	Ability to add/drop Ethernet payload to/from GFP mapped STM-n/OTU signal
Error insertion	Correctable core HEC, uncorrectable core HEC, correctable type HEC, uncorrectable type HEC, correctable extension HEC, uncorrectable extension HEC, payload FCS	Error insertion	Correctable core HEC, uncorrectable core HEC, correctable type HEC, uncorrectable type HEC, correctable extension HEC, uncorrectable extension HEC, payload FCS
Error monitoring	Correctable core HEC, uncorrectable core HEC, correctable type HEC, uncorrectable type HEC, correctable extension HEC, uncorrectable extension HEC, payload FCS	Error monitoring	Correctable core HEC, uncorrectable core HEC, correctable type HEC, uncorrectable type HEC, correctable extension HEC, uncorrectable extension HEC, payload FCS
Alarm insertion	Loss of client signal (LOCS) and loss of client character, synchronization (LOCCS) with configurable time interval between 10 and 1200 ms, loss of frame delineation (LFD), client forward defect indication (FDI), client reverse defect indication (RDI) and client defect clear indication (DCI)	Alarm insertion	Loss of client signal (LOCS) and loss of client character, synchronization (LOCCS) with configurable time interval between 10 and 1200 ms, loss of frame delineation (LFD), client forward defect indication (FDI), client reverse defect indication (RDI) and client defect clear indication (DCI)
Alarm monitoring	Loss of client signal (LOCS), loss of client character synchronization (LOCCS), loss of frame delineation (LFD), client forward defect indication (FDI), client reverse defect indication (RDI) and client defect clear indication (DCI)	Alarm monitoring	Loss of client signal (LOCS), loss of client character synchronization (LOCCS), loss of frame delineation (LFD), client forward defect indication (FDI), client reverse defect indication (RDI) and client defect clear indication (DCI)
Statistics	Transmit: client data frames (including payload bytes), client management frames, total frames, idle frames, GFP bandwidth usage (%), GFP mapping efficiency (%) Receive: client data frames (including payload bytes), client management frames, total frames, idle (control) frames, reserved (control) frames, invalid frames, discarded frames, EXI mismatches, UPI mismatches, CID mismatches, GFP bandwidth usage (%), GFP mapping efficiency (%)	Statistics	Transmit: client data frames (including payload bytes), client management frames, total frames, idle frames, GFP bandwidth usage (%), GFP mapping efficiency (%) Receive: client data frames (including payload bytes), client management frames, total frames, idle (control) frames, reserved (control) frames, invalid frames, discarded frames, EXI mismatches, UPI mismatches, CID mismatches, GFP bandwidth usage (%), GFP mapping efficiency (%)
Header manipulation	PTI, PFI, EXI, UPI, CID and spare (extension header) fields	Header manipulation	PTI, PFI, EXI, UPI, CID and spare (extension header) fields
Header monitoring	PLI, PTI, PFI, EXI, UPI, CID, spare (extension header) fields, cHEC, tHEC, eHEC	Header monitoring	PLI, PTI, PFI, EXI, UPI, CID, spare (extension header) fields, cHEC, tHEC, eHEC
Virtual concatenation (VCAT)		Virtual concatenation (VCAT)	
Standards compliance	Supports high-order and low-order virtual concatenation as per ANSI T1.105	Standards compliance	Supports high-order and low-order virtual concatenation as per ITU G.707
Mappings	High-order STS-1-Xv (X = 1 to 21) STS-3-Xv (X = 1 to 7) Low-order VT1.5-Xv (X = 1 to 64) VT-2-Xv (X = 1 to 64)	Mappings	High-order VC-3-Xv (X = 1 to 21) VC-4-Xv (X = 1 to 7) Low-order VC-11-Xv (X = 1 to 64) VC-12-Xv (X = 1 to 64) VC-3-Xv in AU-4 (X = 1 to 21)
Alarm insertion	LOM, OOM1, OOM2, SQM VCAT and path alarms can be generated independently on any member of a VCG	Alarm insertion	LOM, OOM1, OOM2, SQM VCAT and path alarms can be generated independently on any member of a VCG
Alarm monitoring	LOM, OOM1, OOM2, SQM, LOA	Alarm monitoring	LOM, OOM1, OOM2, SQM, LOA
Differential delay	Analysis Range: 0 to 256 ms Display: numerical and graphical Insertion Range: 0 to 256 ms	Differential delay	Analysis Range: 0 to 256 ms Display: numerical and graphical Insertion Range: 0 to 256 ms
Sequence number manipulation and processing	Sequence range: 0 to 63 Sequence number monitoring: current AcSQ (accepted SQ) monitored against the ExSQ (expected SQ); SQM alarm raised on mismatch	Sequence number manipulation and processing	Sequence range: 0 to 63 Sequence number monitoring: current AcSQ (accepted SQ) monitored against the ExSQ (expected SQ); SQM alarm raised on mismatch

SONET/SDH Functional Specifications (Cont'd)

NEXT-GENERATION SONET/SDH (CONT'D)

Link capacity adjustment scheme (LCAS)

Standards compliance	As per ITU G.7042; supported for both low-order and high-order VCAT groups
Test functions	<ul style="list-style-type: none"> Emulation of source and sink state machines Automatic and manual control of source and sink state machines Independent overwrite capability at the source and sink for each member Automatic SQ management
Source state machine control	<ul style="list-style-type: none"> Add/remove member(s) Configure: RS-ACK timeout, remote DUT, PLCT threshold Statistics count: received RS-ACK, unexpected RS-ACK Error/alarm generation: CRC errors, group ID (GID) mismatch Error/alarm monitoring: loss of partial transport capacity, loss of total transport capacity, failure of protocol transmission, CRC errors, unexpected member status
Sink state machine control	<ul style="list-style-type: none"> Add/remove member(s) Configure Hold-Off and Wait-to-Restore timers, PLCR threshold Toggle RS-ACK Statistics count: transmitted RS-ACK Error/alarm generation: CRC errors, group ID (GID) mismatch Error/alarm monitoring: loss of partial transport capacity, loss of total transport capacity, failure of protocol reception, CRC errors, unexpected member status

ADDITIONAL TEST AND MEASUREMENT FUNCTIONS

Power measurements	Supports power measurements, displayed in dBm (dBdsx for DS1), for optical and electrical interfaces.														
Frequency measurements	Supports clock frequency measurements (i.e., received frequency and deviation of the input signal clock from nominal frequency), displayed in ppm and bit/s (bps), for optical and electrical interfaces.														
Frequency offset generation	Supports offsetting the clock of the transmitted signal on a selected interface to exercise clock recovery circuitry on network elements.														
Dual DS _n receivers	Supports two DS1 or DS3 receivers, allowing users to simultaneously monitor two directions of a circuit under test in parallel, resulting in quick isolation of the source of errors.														
Performance monitoring	<p>The following ITU-T recommendations, and corresponding performance monitoring parameters, are supported on the IQS-8120/8130.</p> <table border="0"> <tr> <td>ITU-T recommendation</td><td>Performance monitoring statistics</td></tr> <tr> <td>G.821</td><td>ES, EFS, EC, SES, UAS, ESR, SESR, DM</td></tr> <tr> <td>G.826</td><td>ES, EFS, EB, SES, BBE, UAS, ERS, SESR, BBER</td></tr> <tr> <td>G.828</td><td>ES, EFS, EB, SES, BBE, SEP, UAS, ESR, SESR, BBER, SEPI</td></tr> <tr> <td>G.829</td><td>ES, EFS, EB, SES, BBE, UAS, ESR, SESR, BBER</td></tr> <tr> <td>M.2100</td><td>ES, SES, UAS, ESR, SESR</td></tr> <tr> <td>M.2101</td><td>ES, SES, BBE, UAS, ESR, SESR, BBER</td></tr> </table>	ITU-T recommendation	Performance monitoring statistics	G.821	ES, EFS, EC, SES, UAS, ESR, SESR, DM	G.826	ES, EFS, EB, SES, BBE, UAS, ERS, SESR, BBER	G.828	ES, EFS, EB, SES, BBE, SEP, UAS, ESR, SESR, BBER, SEPI	G.829	ES, EFS, EB, SES, BBE, UAS, ESR, SESR, BBER	M.2100	ES, SES, UAS, ESR, SESR	M.2101	ES, SES, BBE, UAS, ESR, SESR, BBER
ITU-T recommendation	Performance monitoring statistics														
G.821	ES, EFS, EC, SES, UAS, ESR, SESR, DM														
G.826	ES, EFS, EB, SES, BBE, UAS, ERS, SESR, BBER														
G.828	ES, EFS, EB, SES, BBE, SEP, UAS, ESR, SESR, BBER, SEPI														
G.829	ES, EFS, EB, SES, BBE, UAS, ESR, SESR, BBER														
M.2100	ES, SES, UAS, ESR, SESR														
M.2101	ES, SES, BBE, UAS, ESR, SESR, BBER														
Pointer adjustment and analysis	<p>Generation and analysis of HO/AU and LO/TU pointer adjustments as per GR-253, and ITU-T G.707.</p> <table border="0"> <tr> <td>Generation</td><td>Analysis</td></tr> <tr> <td>• Pointer increment and decrement</td><td>• Pointer increments</td></tr> <tr> <td>• Pointer jump with or without NDF</td><td>• Pointer decrements</td></tr> <tr> <td>• Pointer value</td><td>• Pointer jumps (NDF, no NDF)</td></tr> <tr> <td></td><td>• Pointer value and cumulative offset</td></tr> </table>	Generation	Analysis	• Pointer increment and decrement	• Pointer increments	• Pointer jump with or without NDF	• Pointer decrements	• Pointer value	• Pointer jumps (NDF, no NDF)		• Pointer value and cumulative offset				
Generation	Analysis														
• Pointer increment and decrement	• Pointer increments														
• Pointer jump with or without NDF	• Pointer decrements														
• Pointer value	• Pointer jumps (NDF, no NDF)														
	• Pointer value and cumulative offset														
Programmable errors/alarms injection	Ability to inject errors/alarms in the following modes: Manual, Constant Rate, Burst, Periodic Burst and Continuous.														
Service disruption time (SDT) measurements	<p>The service disruption time test tool measures the time during which there is a disruption of service due to the network switching from the active channels to the backup channels.</p> <p>User-selectable triggers: all supported alarms and errors.</p> <p>Measurements: last disruption, shortest disruption, longest disruption, average disruption, total disruption, and service disruption count.</p>														
Round-trip delay (RTD) measurements	<p>The round-trip delay test tool measures the time required for a bit to travel from the IQS-8120/8130 transmitter back to its receiver after crossing a far-end loopback. Measurements are supported on all supported IQS-8120/8130 interfaces and mappings.</p> <p>Measurements: last RTD time, minimum, maximum, average, measurement count (no. of successful RTD tests), failed measurement count.</p>														
APS message control and monitoring	Ability to monitor and set up automatic protection switching messages (K1/K2 byte of SONET/SDH overhead).														
Synchronization status	Ability to monitor and set up synchronization status messages (S1 byte of SONET/SDH overhead).														
Signal label control and monitoring	Ability to monitor and set up payload signal labels (C2, V5 byte of SONET overhead).														
Through mode	Ability to perform Through mode analysis of any incoming electrical (DS _n , PDH) and optical line (OC-3/STM-1, OC-12/STM-4, OC-48/STM-16, OC-192/STM-64, OTU1, OTU2, OTU1e and OTU2e) either transparently or intrusively.														
M13 mux/demux	Ability to multiplex/demultiplex a DS1 signal into/from a DS3 signal. (Note: E1 to DS3 mux/demux available with G.747 software option.)														
DS1 FDL	Support for DS1 Facility Data Link testing.														
DS1 loopcodes	Support for generation of DS1 in-band loopcodes with the availability of up to 10 pairs of user-defined loopcodes.														
NI/CSU loopback emulation	Ability to respond to DS1 in-band/out-of-band loopcodes.														
DS3 FEAC	Support for DS3 far-end alarms and loopback codewords.														
DS1/DS3 auto detection	Ability to automatically detect DS1/DS3 line coding, framing and test pattern.														
Tandem connection monitoring (TCM) ^a	<p>Tandem connection monitoring (TCM), Option 2 ^b, is used to monitor the performance of a subsection of a SONET/SDH path routed via different network providers. The IQS-8120/8130 supports transmitting and receiving alarms and errors on a TCM link; also, transmission and monitoring of the tandem connection (TC) trace can be generated to verify the connection between TCM equipment.</p> <p>Error generation: TC-IEC, TC-BIP, TC-REI, OEI</p> <p>Error analysis: TC-IEC, TC-REI, OEI, TC-VIOL</p> <p>Alarm generation: TC-RDI, TC-UNEQ, ODI, TC-LTC, TC-IAIS</p> <p>Alarm analysis: TC-TIM, TC-RDI, TC-UNEQ, ODI, TC-LTC, TC-IAIS</p>														
Payload block and replace	Ability to terminate and analyze a specific high-order path element and replace it with a PRBS pattern on the TX side.														
K1/K2 OH byte capture	Ability to capture K1/K2 OH byte value transitions.														

NOTES

- a. HOP and LOP supported.
 b. G.707 option 2.

SONET/SDH Functional Specifications (Cont'd)

ADDITIONAL FEATURES

Scripting	Wide range of SCPI commands powerful enough to provide repeatable testing of complex configuration, yet simple enough to create a 10 gigabit BERT in as little as seven commands. The IQS-8120/8130 also includes an intuitive macro recorder enabling users to easily record test actions and automatically create test scripts in VB.Net.
Reports	Supports generation of test reports in .html, .csv, .txt, .pdf formats. Contents of reports are customizable by the user.
Power-up and restore	In the event of a power failure to the unit, the active test configuration and test logger are saved and restored upon bootstrap.
Store and load configurations	Ability to store and load test configurations to/from non-volatile memory.
Alarm hierarchy	Alarms are displayed according to a hierarchy based on root cause. Secondary effects are not displayed. This hierarchy serves to facilitate alarm analysis.
Configurable test views	This allows users to customize their test views; i.e., to dynamically insert or remove test tabs/windows, in addition to creating new test windows, so as to accurately match their testing needs.
Configurable test timer	Provides the ability for a user to set pre-defined test start and stop times.
Remote control	Available with Windows-based remote management software known as Visual Guardian Lite (optional software package). This allows users to remotely monitor and control the IQS-8120/8130 modules via standard Ethernet connection.

OTN Functional Specifications

OTN	
Standards compliance	ITU-T G.709, ITU G.798, ITU G.872
Interfaces	OTU1 (2.7 Gbit/s), OTU2 (10.7 Gbit/s), OTU1e (11.0491 Gbit/s), OTU2e (11.0957 Gbit/s), OTU1f (11.2701 Gbit/s), OTU2f (11.3176 Gbit/s)
Client types ^a	All supported SONET/SDH mappings (including next-generation GFP, VCAT, LCAS), NULL, PRBS (2E31-1), ODU1 into OTU2 multiplexing
OTU Layer	
Errors	OTU-FAS, OTU-MFAS, OTU-BEI, OTU-BIP-8
Alarms	LOF, OOF, LOM, OOM, OTU-AIS, OTU-TIM, OTU-BDI, OTU-IAE, OTU-BIAE
Traces	64-bytes Trail Trace Identifier (TTI) as defined in ITU-T G.709
ODU TCM Layer	
Errors	TCMi-BIP-8, TCMi-BEI (i = 1 to 6)
Alarms	TCMi-LTC, TCMi-TIM, TCMi-BDI, TCMi-IAE, TCMi-BIAE
Traces	64-bytes Trail Trace Identifier (TTI) as defined in ITU-T G.709
ODU Layer	
Errors	ODU-BIP-8, ODU-BEI
Alarms	ODU-AIS, ODU-OCI, ODU-LCK, ODU-TIM, ODU-BDI, ODU-FSF, ODU-BSF, ODU-FSD, ODU-BSL
Traces	Generates 64-bytes Trail Trace Identifier (TTI) as defined in ITU-T G.709
ODU0	
Muxing	ODU0 into ODU1, ODU0 into ODU2
Client types	Pattern, OC-3/STM-1, OC-12/STM-4, GigE using GFP-T
GFP-T errors	SB Correctable, SB Uncorrectable, 10B_ERR
ODU Multiplexing ^b	
Alarms	OPU-MSIM, ODU-LOFLOM
ODUflex	
Muxing	ODUflex into ODU2
Client types	Ethernet using GFP-F or pattern for constant bit rate (CBR)
OPU Layer	
Alarm	OPU-PLM, OPU-PLM, OPU-CSF, OPU-AIS
Payload type (PT) label	PT value
GMP errors	Cm CRC-8, CnD CRC-5
Forward Error Correction (FEC)	
Errors	FEC-Correctable (Codeword), FEC-Uncorrectable (Codeword), FEC-Correctable (Symbol), FEC-Correctable (Bit), and FEC-Stress (Codeword)
Ethernet over OTN (EoOTN) ^c	
Mapping	Direct mapping into OTU1e or OTU2e; or using GFP-F into OTU2; or using GFP-T into ODU0; or using GFP-F into ODUflex
BERT	Framed layer 2 supported with or without VLAN
Pattern	PRBS 2E9-1, PRBS 2E11-1, PRBS 2E15-1, PRBS 2E20-1, PRBS 2E23-1, PRBS 2E31-1 and up to 10 user patterns Capability to invert patterns
Error insertion	FCS, 64B/66B block (10 GigE), symbol (GigE), bit
Error measurement	Jabber/giant, runt, undersize, oversize, FCS, 64B/66B block (10 GigE), symbol (GigE), idle (GigE), false carrier (GigE)
Error measurement (BERT)	Bit error, bit mismatch 0, bit mismatch 1
Alarm insertion	Link down, local fault, remote fault, pattern loss
Alarm detection	Link down, local fault, remote fault, pattern loss
VLAN	Capability to generate one stream with one layer of VLAN
Ethernet statistics	Multicast, broadcast, unicast, N-unicast, frame size distribution, bandwidth, utilization, frame rate

ADDITIONAL FEATURES

Service disruption time (SDT) measurements	The service disruption time test tool measures the time during which there is a disruption of service due to the network switching from the active channels to the backup channels. User-selectable triggers: all supported alarms and errors. Measurements: last disruption, shortest disruption, longest disruption, average disruption, total disruption, and service disruption count.
Round-trip delay (RTD) measurements	The round-trip delay test tool measures the time required for a bit to travel from the IQS-8120/8130 transmitter back to its receiver after crossing a far-end loopback. Measurements are supported on all supported IQS-8120/8130 interfaces and mappings. Measurements: last RTD time, minimum, maximum, average, measurement count (no. of successful RTD tests), failed measurement count.

NOTES

- Available with ODUMUX option.
- Available on the IQS-8130 and IQS-8130NG only.
- Available on the IQS-8130NG only.

ADDITIONAL SPECIFICATIONS

IQS-8120	IQS-8120NG	IQS-8130	IQS-8130NG
SONET/SDH 2.5 Gbit/s and OTN 2.7 Gbit/s	Next-generation SONET/SDH 2.5 Gbit/s and OTN 2.7 Gbit/s	SONET/SDH 10 Gbit/s and OTN 10.7 Gbit/s	Next-generation SONET/SDH 10 Gbit/s and OTN 10.7 Gbit/s
Analyzer module supporting up to 2.5/2.7 Gbit/s optical rates, as well as electrical DSn/PDH interfaces	Analyzer module supporting up to 2.5/2.7 Gbit/s optical rates, as well as electrical DSn/PDH interfaces.	Analyzer module supporting up to 10/10.7 Gbit/s optical rates, as well as electrical DSn/PDH interfaces	Analyzer module supporting up to 10/10.7 Gbit/s optical rates, as well as electrical DSn/PDH interfaces
Test Interfaces			
OTN: OTU1 (2.7 Gbit/s)	OTN: OTU1 (2.7 Gbit/s)	OTN: OTU1 (2.7 Gbit/s), OTU2 (10.7 Gbit/s)	OTN: OTU1 (2.7 Gbit/s), OTU2 (10.7 Gbit/s)
		OTU1e (11.0491 Gbit/s), OTU2e (11.0957 Gbit/s)	OTU1e (11.0491 Gbit/s), OTU2e (11.0957 Gbit/s)
		OTU1f (11.2701 Gbit/s), OTU2f (11.3176 Gbit/s)	OTU1f (11.2701 Gbit/s), OTU2f (11.3176 Gbit/s)
SONET: STS-1e, STS-3e, OC-3, OC-12, OC-48	SONET: STS-1e, STS-3e, OC-3, OC-12, OC-48	SONET: STS-1e, STS-3e, OC-3, OC-12, OC-48, OC-192	SONET: STS-1e, STS-3e, OC-3, OC-12, OC-48, OC-192
SDH: STM-0e, STM-1e, STM-0, STM-4, STM-16	SDH: STM-0e, STM-1e, STM-0, STM-4, STM-16	SDH: STM-0e, STM-1e, STM-0, STM-4, STM-16, STM-64	SDH: STM-0e, STM-1e, STM-0, STM-4, STM-16, STM-64
DSn: DS1, DS3, Dual DS1 Rx, Dual DS3 Rx	DSn: DS1, DS3, Dual DS1 Rx, Dual DS3 Rx	DSn: DS1, DS3, Dual DS1 Rx, Dual DS3 Rx	DSn: DS-1, DS-3, Dual DS1 Rx, Dual DS3 Rx
PDH: E1, E2, E3, E4	PDH: E1, E2, E3, E4	PDH: E1, E2, E3, E4	PDH: E1, E2, E3, E4
	Ethernet: 10/100/1000M and GigE (for EoS testing)		Ethernet: 10/100/1000M and GigE (for EoS testing)

GENERAL SPECIFICATIONS

	IQS-8120 and IQS-8120NG	IQS-8130 and IQS-8130NG
Weight (without transceiver)	1.4 kg (3.1 lb)	1.4 kg (3.1 lb)
Size (H x W x D)	125 mm x 74 mm x 282 mm (4 ¹⁵ / ₁₆ in x 2 ¹⁵ / ₁₆ in x 11 ¹ / ₈ in)	125 mm x 74 mm x 282 mm (4 ¹⁵ / ₁₆ in x 2 ¹⁵ / ₁₆ in x 11 ¹ / ₈ in)
Temperature		
operating	0 °C to 40 °C (32 °F to 104 °F)	0 °C to 40 °C (32 °F to 104 °F)
storage	-40 °C to 60 °C (-40 °F to 140 °F)	-40 °C to 60 °C (-40 °F to 140 °F)

ORDERING INFORMATION

IQS-81XX-XX-XX-XX-XX-XX-XX-XX

Model ■

See models listed above

Test options ■

SONET = SONET-BASE-SW

SDH = SDH-BASE-SW

SONET-SDH = Software option for combined SONET/SDH functionality

Rate options ^a ■

155 = 155 Mbit/s (OC-3/STM-1)

622 = 622 Mbit/s (OC-12/STM-4)

2.5G = 2.5 Gbit/s (OC-48/STM-16)

10G = 10 Gbit/s (OC-192/STM-64) ^b

All rate enablers come as standard with the IQS-8130 and IQS-8130NG modules.

Transceivers SFP telecom ^a ■

IQS-8190 = Multirate (155/622 Mbit/s, 2.5/2.7 Gbit/s, GigE/FC/2FC) optical SFP transceiver module with LC connector; 1310 nm; 15 km reach

IQS-8191 = Multirate (155/622 Mbit/s, 2.5/2.7 Gbit/s, GigE/FC/2FC) optical SFP transceiver module with LC connector; 1310 nm; 40 km reach

IQS-8192 = Multirate (155/622 Mbit/s, 2.5/2.7 Gbit/s, GigE/FC/2FC) optical SFP transceiver module with LC connector; 1550 nm; 80 km reach

IQS-8193 = Multirate (155/622 Mbit/s, 2.5/2.7 Gbit/s, GigE/FC/2FC) optical SFP transceiver module with LC connector; 1550 nm; 40 km reach

10 Gbit/s transceivers XFP telecom ^{a, b} ■

IQS-81900 = Multirate (10-11.3 Gbit/s) optical XFP transceiver module with LC connector; 1310 nm; 10 km reach

IQS-81901 = Multirate(10/10.7 Gbit/s) optical XFP transceiver module with LC connector; 1550 nm; 40 km reach

IQS-81902 = Multirate(10/10.7 Gbit/s) optical XFP transceiver module with LC connector; 1550 nm; 80 km reach

Optical Ethernet transceivers SFP datacom ^{a, c, d} ■

IQS-8590 = GigE/FC/2FC optical SFP transceiver module with LC connector; 850 nm; MMF, < 500 m reach

IQS-8591 = GigE/FC/2FC optical SFP transceiver module with LC connector; 1310 nm; 10 km reach

IQS-8592 = GigE/FC/2FC optical SFP transceiver module with LC connector; 1550 nm; 90 km reach

Next-generation options ^{a, e}

00 = Without next-generation software

HO-VCAT = High-order virtual concatenation

LO-VCAT = Low-order virtual concatenation

LCAS = Link capacity adjustment scheme ^f

GFP-F = Generic framing procedure—framed

EoS = Ethernet-over-SONET/SDH ^{d, g}

Options ^a

G.747 ^h

DS1-FDL

DS3-FEAC

DUAL-RX

SMART_MODE

TCM = Tandem connection monitoring

OTU1 = OTN optical rate 2.7 Gbit/s

OTU2 = OTN optical rate 10.7 Gbit/s ^b

ODUMUX = ODU MUX functionality ^{b, i}

ODU0 = ODU0 mapping ^j

ODUflex = ODUflex functionality ^k

INTR-THRU-MODE = SONET/SDH intrusive Through mode

OTN-INTR-THRU = OTN intrusive Through mode ^l

OTU2-1e-2e = OTN optical rates 11.0491 Gbit/s and 11.0957 Gbit/s ^b

OTU2-1f-2f = OTN optical rates 11.2701 Gbit/s and 11.3176 Gbit/s ^b

OTU2-GFP-F = 10 GigE LAN over GFP-F into OTU2 ^b

EoOTN = Ethernet over OTN functionality ^l

NOTES

a. Multiple options can be purchased to suit the required test application.

b. Applies only to IQS-8130 and IQS-8130NG models.

c. Enables Ethernet add/drop interface. This option is only applicable for IQS-8120NG and IQS-8130NG modules.

d. Ethernet SFP transceiver must be purchased with the EoS software option.

e. These options are available for IQS-8120NG and IQS-8130NG modules.

f. Must be combined with the HO-VCAT or LO-VCAT option.

g. Must be combined with the GFP-F option.

h. Enables E1/2M in DS3/45M analysis, as per ITU-T G.747 recommendation.

i. Must be combined with the OTU1 and OTU2 options.

j. Must be combined with the OTU1 or OTU2 option.

k. Applicable for IQS-8130NG modules only and must be combined with the OTU2 option.

l. Applicable for IQS-8120NG and IQS-8130NG modules only and must be combined with the OTU2-1e-2e or OTU2-GFP-F option.

Example: IQS-8130NG-SONET-SDH-10G-IQS-8192-IQS-8592-OTU1-HO-VCAT

Complementary Products



IQS-8115 Transport Blazer SONET/SDH Test Module

EXFO's IQS-8115 Transport Blazer test module combines advanced DS_n/PDH and SONET/SDH test functions in a single unit, eliminating the need for multiple, purpose-built test platforms for the testing and troubleshooting of T1/E1 to OC-48/STM-16 circuits. The extensive list of DS_n, SONET, PDH and SDH features available on the IQS-8115 Transport Blazer allows users to perform a wide range of tests from simple bit-error-rate (BER) analysis to more advanced product characterization and troubleshooting.

For more information on the IQS-8115, please refer to its detailed product specification sheet at <http://documents.EXFO.com/specsheets/IQS-8115-ang.pdf>



IQS-8105 Transport Blazer DS_n/PDH and SONET/SDH Electrical Test Module

Housed in the IQS-600 Integrated Qualification System and ideally suited for lab and manufacturing environments, the IQS-8105 Transport Blazer offers capabilities to test traditional TDM DS_n and PDH electrical rates, as well as the SONET and SDH electrical rates up to 155 Mbit/s.

For more information on the IQS-8105, please refer to its detailed product specification sheet at <http://documents.EXFO.com/specsheets/IQS-8105-ang.pdf>

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EXFO is certified ISO 9001 and attests to the quality of these products. This device complies with Part 15 of the FCC Rules. Operation is subject to the following two conditions: (1) this device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation. EXFO has made every effort to ensure that the information contained in this specification sheet is accurate. However, we accept no responsibility for any errors or omissions, and we reserve the right to modify design, characteristics and products at any time without obligation. Units of measurement in this document conform to SI standards and practices. In addition, all of EXFO's manufactured products are compliant with the European Union's WEEE directive. For more information, please visit www.EXFO.com/recycle. Contact EXFO for prices and availability or to obtain the phone number of your local EXFO distributor.

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